











Folder

DRV425-Q1

SBOS988A -AUGUST 2019-REVISED APRIL 2020

DRV425-Q1 Automotive, Integrated Fluxgate Magnetic-Field Sensor

1 Features

AEC-Q100 qualified for automotive applications:

Temperature grade 1: –40°C to +125°C, T_A

Functional Safety-Capable

 Documentation available to aid functional safety system design

· High-precision, integrated fluxgate sensor:

Offset: ±8 µT (max)

Offset drift: ±5 nT/°C (typ)

Gain error: 0.04% (typ)

Gain drift: ±7 ppm/°C (typ)

- Linearity: ±0.1%

Noise: 1.5 nT/√Hz (typ)

Sensor range: ±2 mT (max)

Range and gain adjustable with external resistor

Selectable bandwidth: 47 kHz or 32 kHz

• Precision reference:

Accuracy: 2% (max), drift: 50 ppm/°C (max)

Pin-selectable voltage: 2.5 V or 1.65 V

Selectable ratiometric mode: VDD / 2

Diagnostic features: Overrange and error flags

Supply voltage range: 3.0 V to 5.5 V

2 Applications

- · Battery management system (BMS)
- Inverter and motor control
- DC/DC converter
- · Powertrain current sensor
- Powertrain torque sensor
- · Motor diagnostics and monitoring

3 Description

The DRV425-Q1 automotive device is designed for single-axis magnetic field-sensing applications, and enables electrically-isolated, high-sensitivity, precise dc- and ac-field measurements. The device provides the unique and proprietary, integrated fluxgate sensor (IFG) with an internal compensation coil to support a high-accuracy sensing range of ±2 mT, with a measurement bandwidth of up to 47 kHz. The low offset, offset drift, and noise of the sensor, combined with the precise gain, low gain drift, and very low nonlinearity provided by the internal compensation coil, result in unrivaled magnetic field measurement precision. This high level of sensitivity and accuracy enables more current measurements in high-current busbar applications, such as traction inverters or battery-management systems. Torque sensor or motor diagnostic systems can benefit from the ability to precisely measure the position or displacement of a magnetic field. The output of the DRV425-Q1 is an analog signal proportional to the sensed magnetic field.

The device offers a complete set of features, including an internal difference amplifier, on-chip precision reference, and diagnostic functions to minimize component count and system-level cost.

The device is available in a thermally-enhanced, nonmagnetic, thin WQFN package, with a thermal pad for optimized heat dissipation, and is specified for operation over the automotive temperature range of -40°C to +125°C.

Device Information (1)

PART NUMBER	PACKAGE	BODY SIZE (NOM)
DRV425-Q1	WQFN (20)	4.00 mm × 4.00 mm

(1) For all available packages, see the package option addendum at the end of the data sheet.

Simplified Schematic

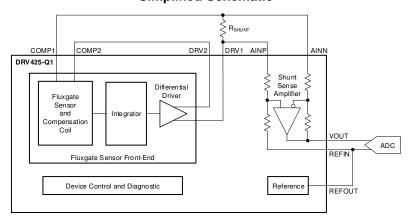




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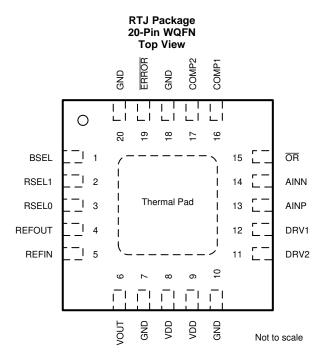
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4 Revision History

Changes from Original (August 2019) to Revision A			е
•	Added Functional Safety-Capable information		1



5 Pin Configuration and Functions



Pin Functions

P	IN		
NAME	NO.	I/O	DESCRIPTION
AINN	14	Ι	Inverting input of the shunt-sense amplifier
AINP	13	Ι	Noninverting input of the shunt-sense amplifier
BSEL	1	I	Filter bandwidth select input
COMP1	16	Ι	Internal compensation coil input 1
COMP2	17	1	Internal compensation coil input 2
DRV1	12	0	Compensation coil driver output 1
DRV2	11	0	Compensation coil driver output 2
ERROR	19	0	Error flag: open-drain, active-low output
GND	7, 10, 18, 20		Ground reference
ŌR	15	0	Shunt-sense amplifier overrange indicator: open-drain, active-low output
REFIN	5	I	Common-mode reference input for the shunt-sense amplifier
REFOUT	4	0	Voltage reference output
RSEL0	3	Ι	Voltage reference mode selection input 0
RSEL1	2	1	Voltage reference mode selection input 1
VDD	8, 9		Supply voltage, 3.0 V to 5.5 V. Decouple both pins using 1-µF ceramic capacitors placed as close as possible to the device. See the <i>Power Supply Decoupling</i> and <i>Layout</i> sections for further details.
VOUT	6	0	Shunt-sense amplifier output
Thermal Pad	Thermal Pad	_	Connect the thermal pad to GND

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6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
	Supply voltage (VDD to GND)	-0.3	6.5	
Voltage	Input voltage, except AINP and AINN pins (2)	GND - 0.5	VDD + 0.5	V
	Shunt-sense amplifier inputs (AINP and AINN pins) (3)	GND - 6.0	VDD + 6.0	
	DRV1 and DRV2 pins (short-circuit current, I _{OS}) (4)	-300	300	
Current	Shunt-sense amplifier input pins AINP and AINN	-5	5	mA
	All remaining pins	-25	25	
Tomporoturo	Junction, T _J	-50	150	°C
Temperature	Storage, T _{stg}	-65	150	C

⁽¹⁾ Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings

			VALUE	UNIT
	Human-body model (HBM), per AEC Q100-002 ⁽¹⁾ HBM ESD classification level 2	±2000		
V(ESD)	Electrostatic discharge	Charged-device model (CDM), per AEC Q100-011 CDM ESD classification level C6	±1000	V

⁽¹⁾ AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

	• · · · · · · · · · · · · · · · · · · ·	,			
		MIN	NOM	MAX	UNIT
VDD	Supply voltage range (VDD to GND)	3.0	5.0	5.5	V
T _A	Specified ambient temperature	-40		125	°C

6.4 Thermal Information

	THERMAL METRIC ⁽¹⁾	RTJ (WQFN)	UNIT
		20 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	34.1	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	33.1	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	11	°C/W
ΨЈТ	Junction-to-top characterization parameter	0.3	°C/W
ΨЈВ	Junction-to-board characterization parameter	11	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	2.1	°C/W

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report.

Product Folder Links: DRV425-Q1

⁽²⁾ Input pins are diode-clamped to the power-supply rails. Input signals that can swing more than 0.5 V beyond the supply rails must be current limited, except for the differential amplifier input pins.

⁽³⁾ These inputs are not diode-clamped to the power-supply rails.

⁽⁴⁾ Power-limited; observe maximum junction temperature.



6.5 Electrical Characteristics

all minimum and maximum specifications are at $T_A = 25$ °C, VDD = 3.0 V to 5.5 V, and $I_{DRV1} = I_{DRV2} = 0$ mA (unless otherwise noted); typical values are at VDD = 5.0 V.

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
FLUXGATE	SENSOR FRONT-END	1201 00112111011				
	Offset	No magnetic field	-8	±2	8	μT
	Offset drift	No magnetic field		±5		nT/°C
G	Gain	Current at DRV1 and DRV2 outputs		12.2		mA/mT
	Gain error			±0.04%		
	Gain drift	Best-fit line method		±7		ppm/°C
	Linearity error			0.1%		11
	Hysteresis	Magnetic field sweep from -10 mT to 10 mT		1.4		μT
	Noise	f = 0.1 Hz to 10 Hz		17		nTrms
	Noise density	f = 1 kHz		1.5		nT/√Hz
	Compensation range		-2		2	mT
	Saturation trip level for the ERROR pin ⁽¹⁾	Open-loop, uncompensated field		1.6		mT
	ERROR delay	Open-loop at B > 1.6 mT		4 to 6		μs
		BSEL = 0, R_{SHUNT} = 22 Ω		32		
BW	Bandwidth	BSEL = 1, R_{SHUNT} = 22 Ω		47		kHz
		VDD = 5 V		250		
I _{OS}	Short-circuit current	VDD = 3.3 V		150		mA
	Common-mode output voltage at DRV1 and DRV2 pins			V _{REFOUT}		V
	Compensation coil resistance			100		Ω
SHUNT-SEI	NSE AMPLIFIER					
V _{oo}	Output offset voltage	$V_{AINP} = V_{AINN} = V_{REFIN}$, VDD = 3.0 V	-0.075	±0.01	0.075	mV
00	Output offset voltage drift	OUAL OUAL INTERIOR	-2	±0.4	2	μV/°C
CMRR	Common-mode rejection ratio, R	TO ⁽²⁾ V _{CM} = -1 V to VDD + 1 V, V _{REFIN} = VDD / 2	-250	±50	250	μV/V
PSRR _{AMP}	Power-supply rejection ratio, RT0	- 1121111	-86	±4	86	μV/V
V _{ICR}	Common-mode input voltage ran		-1		VDD + 1	V
Z _{id}	Differential input impedance	5-	16.5	20	23.5	kΩ
Z _{ic}	Common-mode input impedance		40	50	60	kΩ
G _{nom}	Nominal gain	V _{VOUT} / (V _{AINP} – V _{AINN})	-	4		V/V
E _G	Gain error	VOOT (VAINT VAINT)	-0.3%	±0.02%	0.3%	.,,
<u>-</u> G	Gain error drift		-5	±1	5	ppm/°C
	Linearity error			12		ppm
	Voltage output swing from negati	ve VDD = 5.5 V, I _{VOUT} = 2.5 mA		48	85	
	rail (OR pin trip level) ⁽¹⁾	VDD = 3.0 V, I _{VOUT} = 2.5 mA		56	100	mV
	Voltage output outing from positio	\/DD_	VDD - 85	VDD – 48		
	Voltage output swing from positive (OR pin trip level) (1)	VDD = 3.0 V, I _{VOUT} = -2.5 mA	VDD - 100	VDD - 56		mV
	Signal overrange indication delay (OR pin) ⁽¹⁾			2.5 to 3.5		μs
		VOUT connected to GND		-18		
los	Short-circuit current	VOUT connected to VDD		20		mA
BW _{-3dB}	Bandwidth			2		MHz
SR	Slew rate			6.5		V/µs
	Large sign	al $\Delta V = \pm 2 V$ to 1%, no external filter		0.9		
t _{sa}	Settling time Small sign			8		μs
e _n	Output voltage noise density	f = 1 kHz, compensation loop disabled		170		nV/√ Hz
V _{REFIN}	Input voltage range at pin REFIN		GND		VDD	V

¹⁾ See the Magnetic Field Range, Overrange Indicator, and Error Flag section for details on the behavior of the ERROR and OR outputs.

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⁽²⁾ Parameter value is referred-to-output (RTO).



Electrical Characteristics (continued)

all minimum and maximum specifications are at $T_A = 25$ °C, VDD = 3.0 V to 5.5 V, and $I_{DRV1} = I_{DRV2} = 0$ mA (unless otherwise noted); typical values are at VDD = 5.0 V.

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
VOLTAGE	REFERENCE					
	Reference output voltage at the	RSEL[1:0] = 00, no load	2.45	2.5	2.55	V
V _{REFOUT}		RSEL[1:0] = 01, no load	1.6	1.65	1.7	V
* REFOUT	REFOUT pin	RSEL[1:0] = 1x, no load	45	50	55	% of VDD
	Reference output voltage drift	RSEL[1:0] = 0x	-50	±10	50	ppm/°C
	Voltage divider gain error drift	RSEL[1:0] = 1x	-50	±10	50	ppm/°C
PSRR _{REF}	Power-supply rejection ratio	RSEL[1:0] = 0x	-300	±15	300	μV/V
437	Load regulation	RSEL[1:0] = 0x, load to GND or VDD, $\Delta I_{LOAD} = 0$ mA to 5 mA, $T_A = -40^{\circ}$ C to +125°C		0.15	0.35	mV/mA
$\Delta V_{O(\Delta IO)}$		RSEL[1:0] = 1x, load to GND or VDD, $\Delta I_{LOAD} = 0$ mA to 5 mA, $T_A = -40^{\circ}$ C to +125°C		0.3	8.0	mv/ma
	Chart aircuit aurrant	REFOUT connected to VDD		20		mA
Ios	Short-circuit current	REFOUT connected to GND		-18		mA
DIGITAL IN	NPUTS/OUTPUTS (CMOS)					
I _{IL}	Input leakage current			0.01		μΑ
V_{IH}	High-level input voltage	$T_A = -40^{\circ}C \text{ to } +125^{\circ}C$	0.7 × VDD		VDD + 0.3	V
V_{IL}	Low-level input voltage	$T_A = -40^{\circ}C \text{ to } +125^{\circ}C$	-0.3		0.3 × VDD	V
V _{OH}	High-level output voltage	Open-drain output	Set by exte	rnal pullup r	esistor	V
V _{OL}	Low-level output voltage	4-mA sink current		0.3		V
POWER SI	UPPLY					
	Quiescent current	$I_{DRV1/2} = 0$ mA, 3.0 V \leq VDD \leq 3.6 V, $T_A = -40$ °C to $+125$ °C		6	8	mA
lQ	Quiescent current	$I_{DRV1/2} = 0$ mA, 4.5 V \leq VDD \leq 5.5 V, $T_A = -40$ °C to $+125$ °C		7	10	MA
V _{POR}	Power-on reset threshold			2.4		V

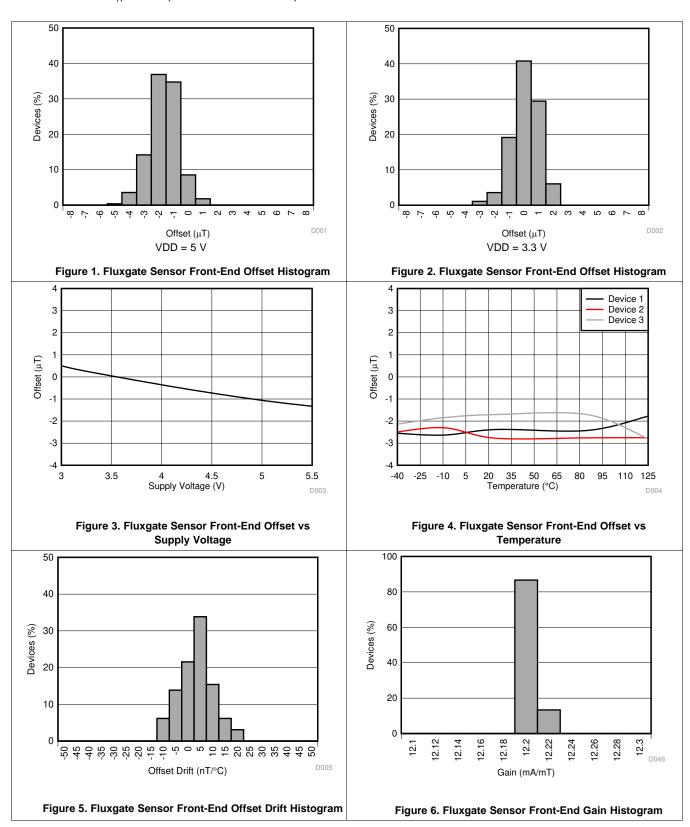
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6.6 Typical Characteristics

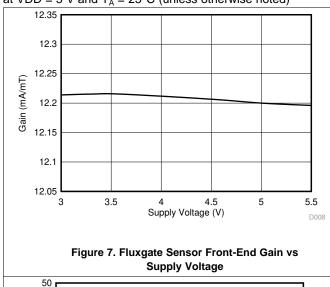
at VDD = 5 V and T_A = 25°C (unless otherwise noted)



TEXAS INSTRUMENTS

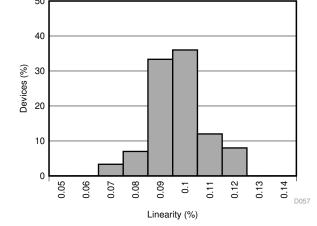
Typical Characteristics (continued)

at VDD = 5 V and T_A = 25°C (unless otherwise noted)



12.35 Device 1 Device 2 12.3 Device 3 12.25 Gain (mA/mT) 12.2 12.15 12.1 12.05 -40 -25 -10 5 35 50 65 95 110 125 Temperature (°C)

Figure 8. Fluxgate Sensor Front-End Gain vs Temperature



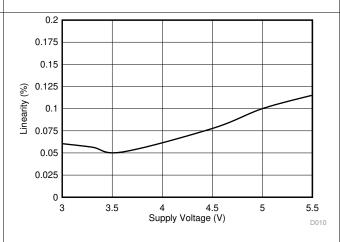
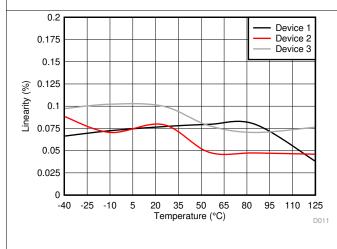


Figure 9. Fluxgate Sensor Front-End Linearity Histogram

Figure 10. Fluxgate Sensor Front-End Linearity vs Supply Voltage



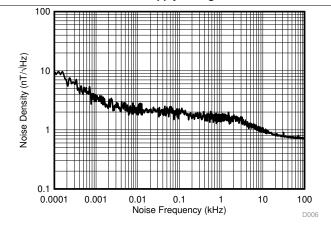


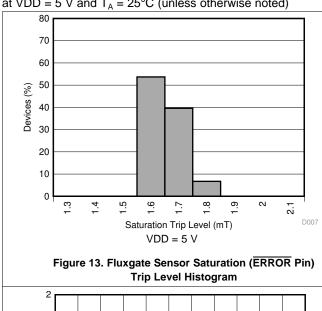
Figure 11. Fluxgate Sensor Front-End Linearity vs
Temperature

Figure 12. Fluxgate Sensor Front-End Noise Density vs Noise Frequency



Typical Characteristics (continued)

at VDD = 5 V and T_A = 25°C (unless otherwise noted)



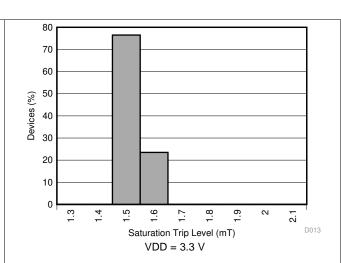


Figure 14. Fluxgate Sensor Saturation (ERROR Pin) Trip Level Histogram

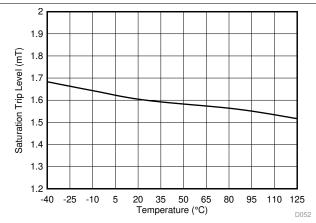


Figure 15. Fluxgate Sensor Saturation (ERROR Pin) Trip Level vs Temperature

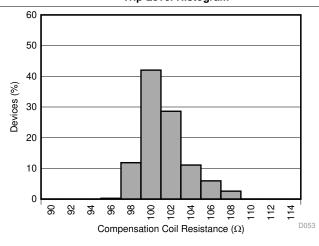


Figure 16. Compensation Coil Resistance Histogram

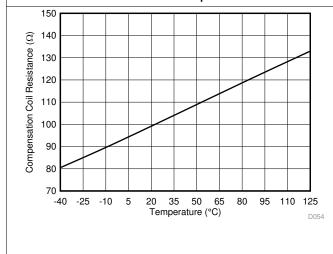


Figure 17. Compensation Coil Resistance vs Temperature

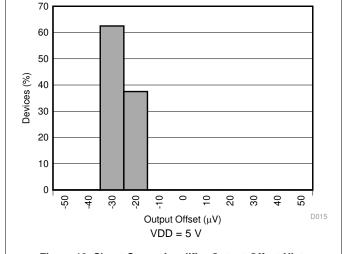
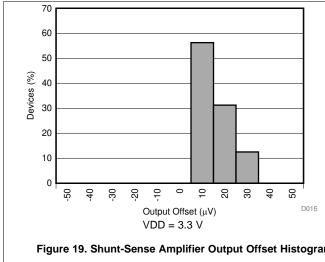


Figure 18. Shunt-Sense Amplifier Output Offset Histogram

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Typical Characteristics (continued)

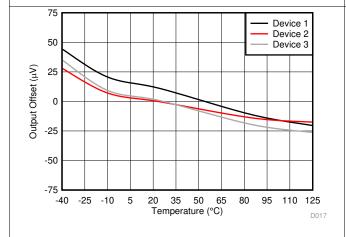
at VDD = 5 V and T_A = 25°C (unless otherwise noted)



75 50 Output Offset (µV) 25 0 -25 -50 -75 3.5 5.5 Supply Voltage (V) D018

Figure 19. Shunt-Sense Amplifier Output Offset Histogram

Figure 20. Shunt-Sense Amplifier Output Offset vs **Supply Voltage**



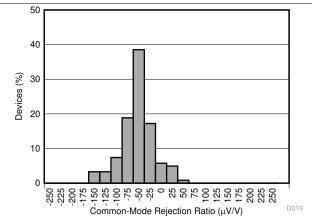
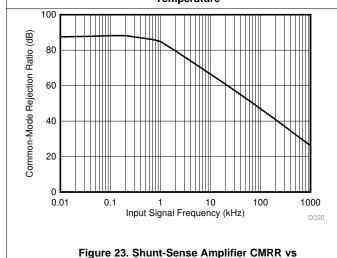


Figure 21. Shunt-Sense Amplifier Output Offset vs **Temperature**

Figure 22. Shunt-Sense Amplifier CMRR Histogram



Input Signal Frequency

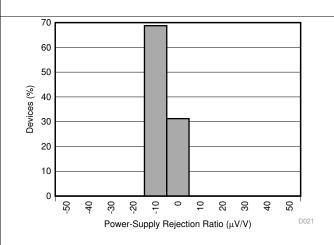
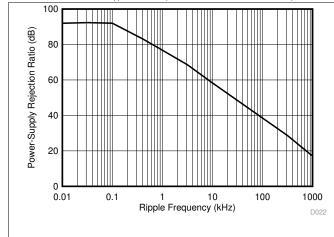


Figure 24. Shunt-Sense Amplifier PSRR Histogram



Typical Characteristics (continued)

at VDD = 5 V and T_A = 25°C (unless otherwise noted)



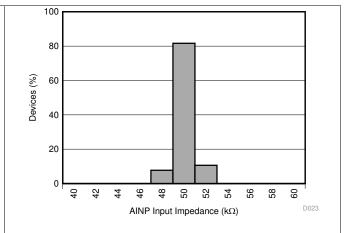
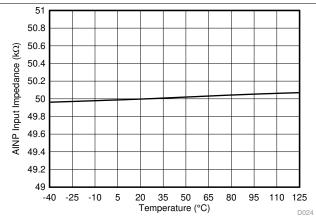


Figure 25. Shunt-Sense Amplifier PSRR vs Ripple Frequency

Figure 26. Shunt-Sense Amplifier AINP Input Impedance Histogram



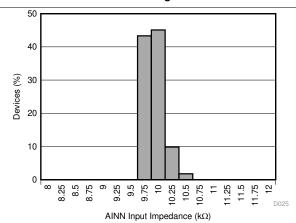
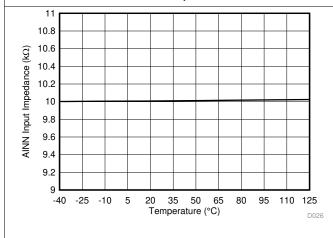


Figure 27. Shunt-Sense Amplifier AINP Input Impedance vs Temperature

Figure 28. Shunt-Sense Amplifier AINN Input Impedance Histogram



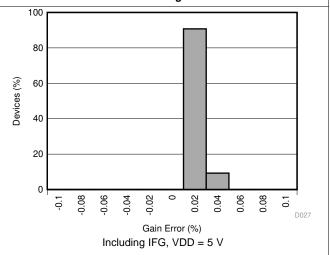


Figure 29. Shunt-Sense Amplifier AINN Input Impedance vs Temperature

Figure 30. Shunt-Sense Amplifier Gain Error Histogram

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NSTRUMENTS

Typical Characteristics (continued)

at VDD = 5 V and T_A = 25°C (unless otherwise noted)

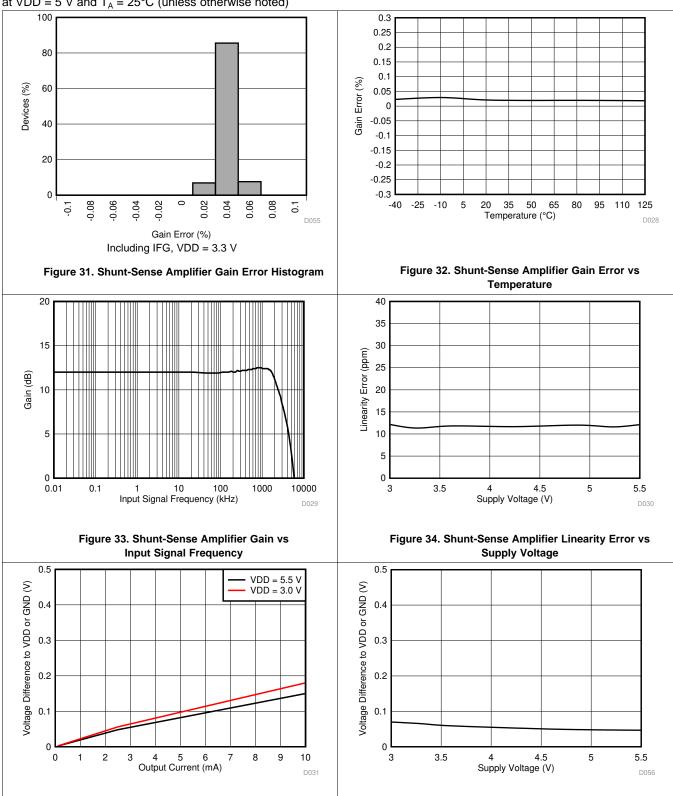


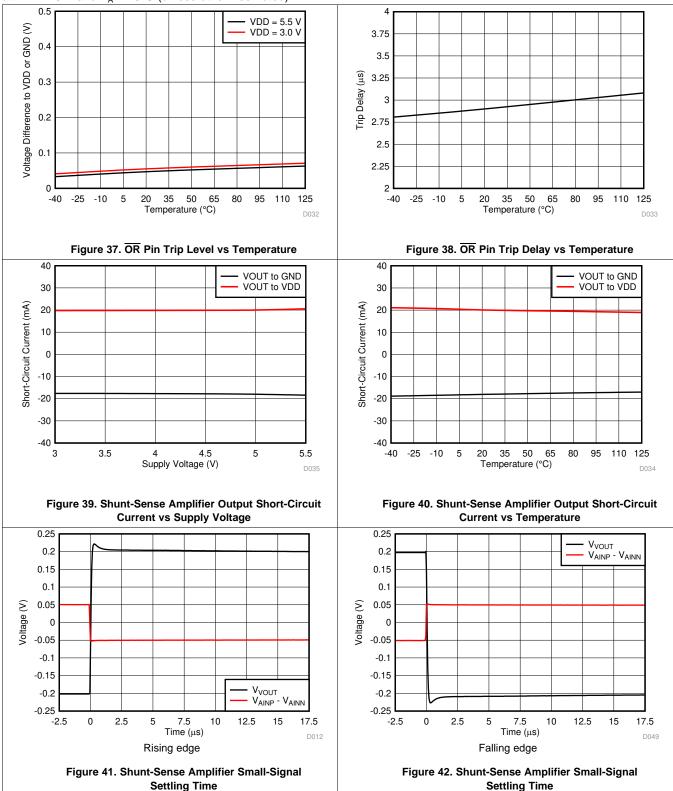
Figure 35. OR Pin Trip Level vs Output Current

Figure 36. OR Pin Trip Level vs Supply Voltage



Typical Characteristics (continued)

at VDD = 5 V and $T_A = 25$ °C (unless otherwise noted)



TEXAS INSTRUMENTS

Typical Characteristics (continued)

at VDD = 5 V and T_A = 25°C (unless otherwise noted)

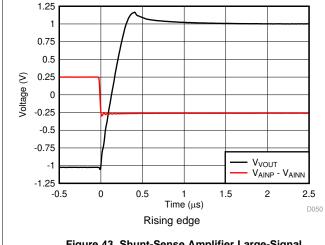


Figure 43. Shunt-Sense Amplifier Large-Signal Settling Time

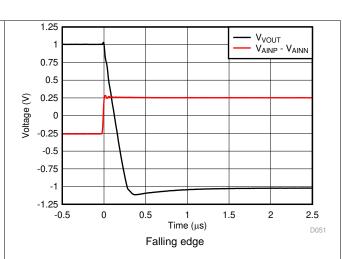


Figure 44. Shunt-Sense Amplifier Large-Signal Settling Time

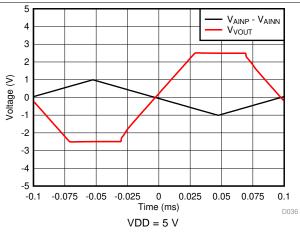


Figure 45. Shunt-Sense Amplifier Overload Recovery Response

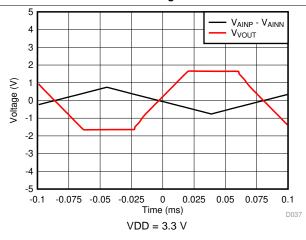


Figure 46. Shunt-Sense Amplifier Overload Recovery Response

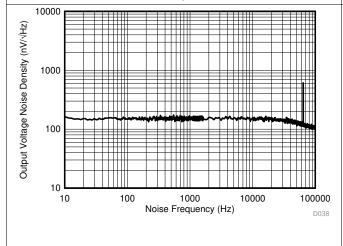


Figure 47. Shunt-Sense Amplifier Output Voltage Noise Density vs Noise Frequency

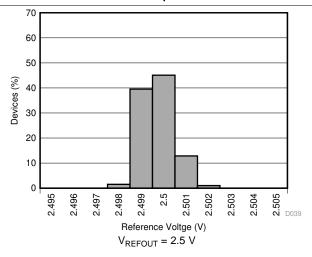
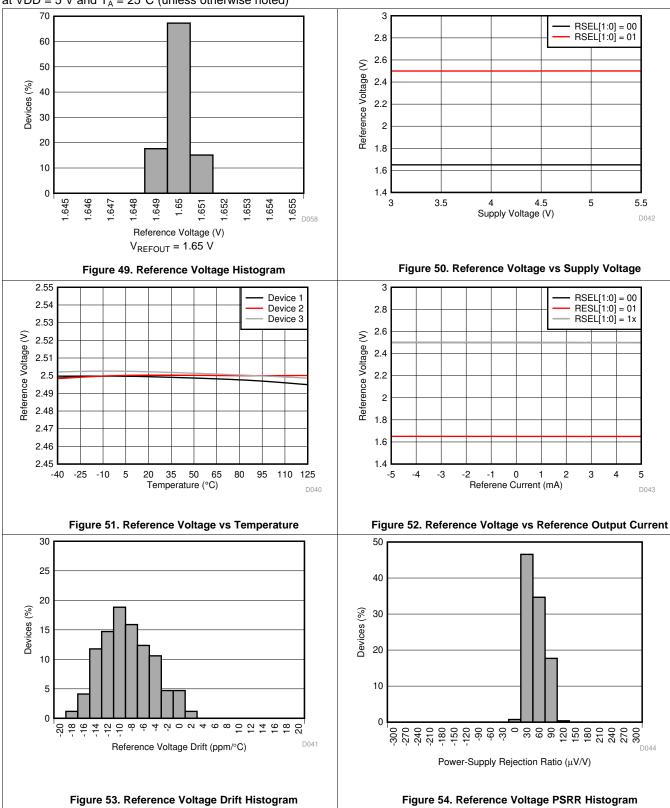


Figure 48. Reference Voltage Histogram



Typical Characteristics (continued)

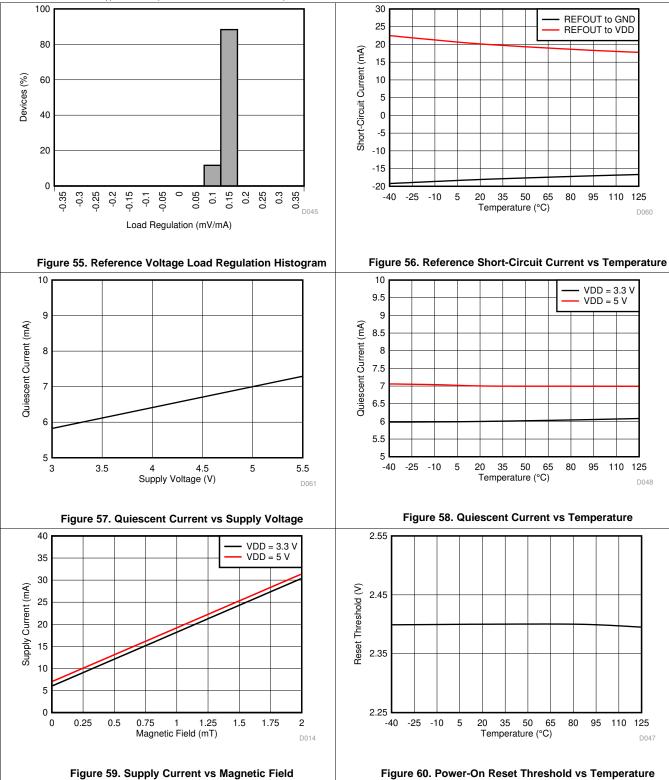
at VDD = 5 V and T_A = 25°C (unless otherwise noted)



TEXAS INSTRUMENTS

Typical Characteristics (continued)

at VDD = 5 V and T_A = 25°C (unless otherwise noted)





7 Detailed Description

7.1 Overview

Magnetic sensors are used in a broad range of applications, such as position, indirect ac and dc current, or torque measurement. Hall-effect sensors are most commonly used in magnetic field sensing, but offset, noise, gain variation, and nonlinearity limit the achievable resolution and accuracy of the system. Fluxgate sensors offer significantly higher sensitivity, lower drift, lower noise, high linearity, and enable up to 1000-times better measurement accuracy.

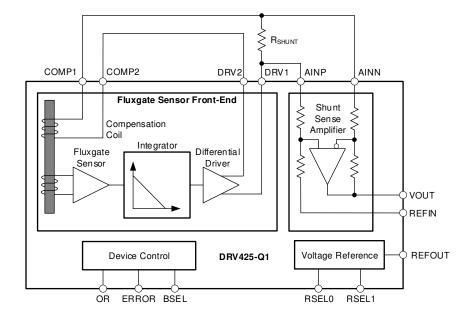
As shown in the *Functional Block Diagram* section, the DRV425-Q1 consists of a magnetic fluxgate sensor with the necessary sensor conditioning and compensation coil to internally close the control loop. The fluxgate sensor is repeatedly driven in and out of saturation, and supports hysteresis-free operation with excellent accuracy. The internal compensation coil assures stable gain and high linearity.

The magnetic field, B, is detected by the internal fluxgate sensor in the DRV425-Q1. The device integrates the sensor output to assure high-loop gain. The integrator output connects to the built-in differential driver that drives an opposing compensation current through the internal compensation coil. The compensation coil generates an opposite magnetic field that brings the original magnetic field at the sensor back to zero.

The compensation current is proportional to the external magnetic field, with a value of 12.2 mA/mT. This compensation current generates a voltage drop across an external shunt resistor, R_{SHUNT} . An integrated difference amplifier with a fixed gain of 4 V/V measures this voltage and generates an output voltage that is referenced to REFIN, and is proportional to the magnetic field. The value of the output voltage at the VOUT pin (V_{VOLIT}) is calculated using Equation 1:

$$V_{VOUT}[V] = B \times G \times R_{SHUNT} \times G_{AMP} = B [mT] \times 12.2 \text{ mA/mT} \times R_{SHUNT}[\Omega] \times 4 [V/V]$$
(1)

7.2 Functional Block Diagram





7.3 Feature Description

7.3.1 Fluxgate Sensor Front-End

The following sections describe the functional blocks and features of the integrated fluxgate sensor front-end.

7.3.1.1 Fluxgate Sensor

The fluxgate sensor of the DRV425-Q1 is uniquely designed for high-performance magnetic-field sensors because of the high sensitivity, low noise, and low offset of the sensor. The fluxgate principle relies on repeatedly driving the sensor in and out of saturation; therefore, the sensor is free of any significant magnetic hysteresis. The feedback loop accurately drives a compensation current through the integrated compensation coil and drives the magnetic field at the sensor back to zero. This approach supports excellent gain stability and high linearity of the measurement.

The device package is free of any ferromagnetic materials in order to prevent magnetization by external fields and to obtain accurate and hysteresis-free operation. Select materials that cannot be magnetized for the printed circuit board (PCB) and passive components in the direct vicinity of the DRV425-Q1; see the *Layout Guidelines* section for more details.

The orientation and the sensitivity axis of the fluxgate sensor is indicated by a dashed line on the top of the package, as shown in Figure 61. The figure also shows the location of the sensor inside the package.

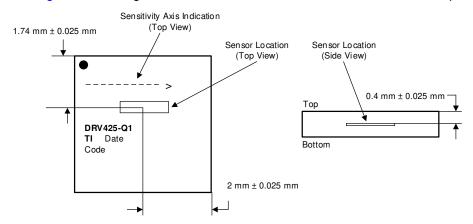


Figure 61. Magnetic Sensitivity Direction of the Integrated Fluxgate Sensor

The sensitivity of the fluxgate sensor is a vector function of the sensitivity axis and the magnitude of the magnetic field along that axis. Figure 62 shows the output of the DRV425-Q1 versus the angle of the device orientation relative to a constant magnetic field.

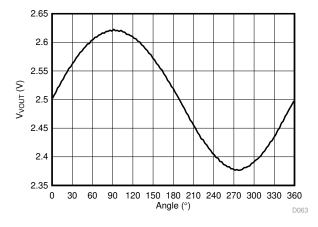


Figure 62. Device Output vs Magnetic Field Orientation

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7.3.1.2 Bandwidth

The small-signal bandwidth of the DRV425-Q1 is determined by the behavior of the compensation loop versus frequency. The implemented integrator limits the bandwidth of the loop to provide a stable response. Use digital input pin BSEL to select the bandwidth. With a shunt resistor of 22 Ω and BSEL = 0, the bandwidth is 32 kHz; for BSEL = 1, the bandwidth is 47 kHz.

The shunt resistor and the compensation coil resistance form a voltage divider; therefore, to reduce the bandwidth, increase the value of the shunt resistor. To calculate the reduced bandwidth (BW), use Equation 2:

$$BW = \frac{R_{COIL} + 22~\Omega}{R_{COIL} + R_{SHUNT}} \times BW_{22~\Omega} = \frac{122~\Omega}{100~\Omega + R_{SHUNT}} \times BW_{22~\Omega}$$

where

- R_{COIL} = internal compensation coil resistance (100 Ω).
- R_{SHUNT} = external shunt resistance.
- BW₂₂₀ = sensor bandwidth with R_{SHUNT} = 22 Ω (depending on the BSEL setting). (2)

The bandwidth for a given shunt resistor value can also be calculated using the DRV425 System Parameter Calculator. For large magnetic fields (B > 500 μ T), the effective bandwidth of the sensor is limited by fluxgate saturation effects. For a magnetic signal with a 2-mT amplitude, the large-signal bandwidth is 10 kHz with BSEL = 0, or 15 kHz with BSEL = 1.

Although the analog output responds slowly to large fields, a magnetic field with a magnitude ≥ 1.6 mT beyond the measurement range of the DRV425-Q1 triggers the ERROR pin within 4 µs to 6 µs. See the *Magnetic Field Range, Overrange Indicator, and Error Flag* section for more details.

7.3.1.3 Differential Driver for the Internal Compensation Coil

The differential compensation coil driver provides the current for the internal compensation coil at the DRV1 and DRV2 pins. The driver is capable of sourcing up to ±250 mA with a 5-V supply, or up to ±150 mA with a 3.3-V supply. The current capability is not internally limited. The actual value of the compensation coil current depends on the magnetic field strength, and is limited by the sum of the resistance of the internal compensation coil and the external shunt resistor value. The internal compensation coil resistance depends on temperature (see Figure 17), and this dependancy must be taken into account when designing the system. Select the value of the shunt resistor to avoid \overline{OR} pin trip levels in normal operation.

The common-mode voltage of the compensation coil driver outputs is set by the RSEL pins; see the *Voltage Reference* section. Thus, the common-mode voltage of the shunt-sense amplifier is matched if the internal reference is used.

Consider the polarity of the compensation coil connection to the output of the compensation coil driver. If the polarity is incorrect, then the driver output drives to the power-supply rails, even at low primary-current levels. In this case, interchange the connection of the DRV1 and DRV2 pins to the compensation coil.

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7.3.1.4 Magnetic Field Range, Overrange Indicator, and Error Flag

The measurement range of the DRV425-Q1 is determined by the amount of current driven into the compensation coil and the output voltage range of the shunt-sense amplifier. The maximum compensation current is limited by the supply voltage and the series resistance of the compensation coil and the shunt.

The magnetic field range is adjusted with the external shunt resistor. The *DRV425 System Parameter Calculator* provides the maximum shunt resistor values depending on the supply voltage (VDD) and the selected reference voltage (V_{RFFIN}) for various magnetic field ranges.

For proper operation at a maximum field (B_{MAX}), choose a shunt resistor (R_{SHUNT}) using Equation 3:

$$R_{SHUNT} \leq \frac{min\Big(\big(VDD - V_{REFIN}\big), V_{REFIN}\Big) - 0.085\ V}{B_{MAX} \times 12.2\ A/T \times 4\ V/V}$$

where

- VDD = minimum supply voltage of the DRV425-Q1 (V).
- V_{REFIN} = common-mode voltage of the shunt-sense amplifier (V).

Alternatively, to adjust the output voltage of the DRV425-Q1 for a desired maximum voltage ($V_{VOUTMAX}$), use Equation 4:

$$R_{SHUNT} \leq \frac{V_{VOUTMAX} - V_{REFIN}}{B_{M\Delta X} \times 12.2 \text{ A/T} \times 4 \text{ V/V}}$$

where

- V_{VOUTMAX} = desired maximum output voltage at VOUT pin (V).
- B_{MAX} = desired magnetic field range (T).

To avoid railing of the compensation coil driver, make sure that Equation 5 is fulfilled:

$$\frac{B_{MAX} \times (R_{COIL} + R_{SHUNT}) \times 12.2A \ / \ T}{2} + 0.1V \leq min\Big(\Big(VDD - V_{REFIN} \Big), V_{REFIN} \Big)$$

where

- B_{MAX} = desired magnetic field range (T).
- R_{COII} = compensation coil resistance (Ω).
- VDD = minimum supply voltage of the DRV425-Q1 (V).
- V_{REFIN} = selected internal reference voltage value (V).

The DRV425 System Parameter Calculator is designed to assist with selecting the system parameters.

The DRV425-Q1 offers two diagnostic output pins to detect large fields that exceed the measurement range of the sensor: the overrange indicator (OR) and the ERROR flag.

In normal operation, the DRV425-Q1 sensor feedback loop compensates the magnetic field inside the fluxgate to zero. Therefore, a large field inside the fluxgate indicates that the feedback loop is not properly working, and the sensor output is invalid. To detect this condition, the ERROR pin is pulled low if the internal field exceeds 1.6 mT. The ERROR output is suppressed for 4 µs to 6 µs to prevent an undesired reaction to transients or noise. For static and slowly varying ambient fields, the ERROR pin triggers when the ambient field exceeds the sensor measurement range by more than 1.6 mT. For dynamic magnetic fields that exceed the sensor bandwidth as specified in the *Specifications* section, the feedback loop response is too slow to accurately compensate the internal field to zero. Therefore, high-frequency fields can trigger the ERROR pin, even if the ambient field does not exceed the measurement range by 1.6 mT.

In addition, the active-low overrange pin (\overline{OR}) indicates railing of the output of the shunt-sense amplifier. The \overline{OR} output is suppressed for 2.5 μ s to 3.5 μ s to prevent an undesired reaction to transients or noise. The \overline{OR} pin trip level refers to the output voltage value of the shunt-sense amplifier, as specified in the *Specifications* section. Use Equation 3 and Equation 4 to adjust the \overline{OR} pin behavior to the specific system-level requirements.

Both the ERROR and OR pins are open-drain outputs that require an external pullup resistor. If desired, connect both pins together with a single pullup resistor to provide a single diagnostic flag.



Based on the *DRV425 System Parameter Calculator*, for a design for a ± 2 -mT magnetic field input range with a supply of 5 V ($\pm 5\%$), a shunt resistor value of 22 Ω is selected. Figure 63 shows the status of the diagnostic flags in the resulting three operation ranges.

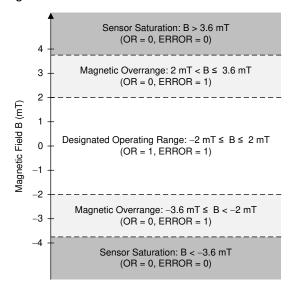


Figure 63. Magnetic Field Range of the DRV425-Q1 (VDD = 5 V and R_{SHUNT} = 22 Ω)

With the proper R_{SHUNT} value, the differential amplifier output rails and activates the overrange flag (OR = 0) when the magnetic field exceeds the designated operating range. For fields that exceed the measurement range of the DRV425-Q1 by \geq 1.6 mT, the fluxgate is saturated and the ERROR pin is pulled low. In this condition, the fluxgate sensor does not provide a valid output value; therefore, the output VOUT of the DRV425-Q1 must be ignored. In applications where the ERROR pin cannot be separately monitored, combine the VOUT and ERROR outputs as shown in Figure 64. This method indicates that a magnetic field is outside of the sensor range by pulling the device output to ground.

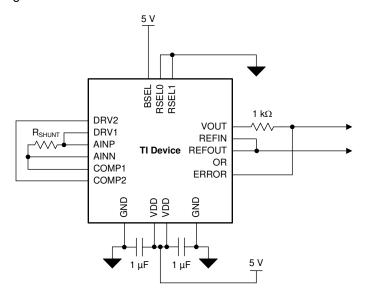


Figure 64. Field Overrange Detection Using a Combined VOUT and ERROR Pin

7.3.2 Shunt-Sense Amplifier

The compensation coil current creates a voltage drop across the external shunt resistor, R_{SHUNT} . The internal differential amplifier senses this voltage drop. This differential amplifier offers wide bandwidth and a high slew rate. Excellent dc stability and accuracy result from a chopping technique. The voltage gain is 4 V/V, set by precisely matched and thermally stable internal resistors.

Both the AINN and AINP differential amplifier inputs are connected to the external shunt resistor. This shunt resistor, in series with the internal 10-k Ω input resistors of the shunt-sense amplifier, causes an additional gain error. Therefore, for best common-mode rejection performance, place a dummy shunt resistor (R_5) with a value higher than the shunt resistor in series with the REFIN pin to restore the matching of both resistor dividers, as shown in Figure 65.

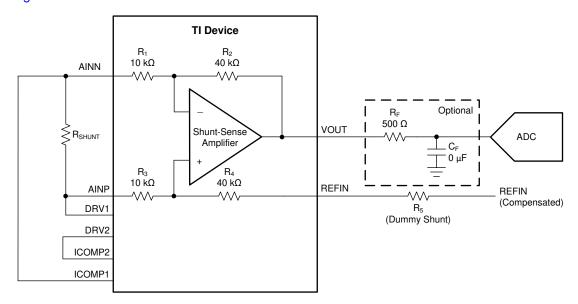


Figure 65. Internal Difference Amplifier With an Example of a Decoupling Filter

For an overall gain of 4 V/V, calculate the value of R₅ using Equation 6:

$$4 = \frac{R_2}{R_1} = \frac{R_4 + R_5}{R_{SHUNT} + R_3}$$

where:

•
$$R_2 / R_1 = R_4 / R_3 = 4$$
.

•
$$R_5 = R_{SHUNT} \times 4$$
.

If the input signal is large, the amplifier output drives close to the supply rails. The amplifier output is able to drive the input of a successive approximation register (SAR) analog-to-digital converter (ADC). For best performance, add an RC low-pass filter stage between the shunt-sense amplifier output and the ADC input. This filter limits the noise bandwidth, and decouples the high-frequency sampling noise of the ADC input from the amplifier output. For filter resistor R_F and filter capacitor C_F values, see the specific converter recommendations in the respective product data sheet.

The shunt-sense amplifier output drives 100 pF directly, and shows a 50% overshoot with a 1-nF capacitance. Filter resistor R_F extends the capacitive load range. With an R_F of only 20 Ω , the load capacitor must be either less than 1 nF or more than 33 nF to avoid overshoot; with an R_F of 50 Ω , this transient area is avoided.

Reference input REFIN is the common-mode voltage node for the output signal VOUT. To use the internal voltage reference of the DRV425-Q1, connect the REFIN pin to the reference output REFOUT. To avoid mismatch errors, use the same reference voltage for REFIN and the ADC. Alternatively, use an ADC with a pseudodifferential input, with the positive input of the ADC connected to VOUT, and the negative input connected to REFIN of the device.



7.3.3 Voltage Reference

The internal precision voltage reference circuit offers low-drift performance at the REFOUT output pin, and is used for internal biasing. The reference output is intended to be the common-mode voltage of the output (the VOUT pin) to provide a bipolar signal swing. This low-impedance output tolerates sink and source currents of ± 5 mA. However, fast load transients can generate ringing on this line. A small series resistor of a few ohms improves the response, particularly for capacitive loads equal to or greater than 1 μ F.

To adjust the value of the voltage reference output to the power supply of the DRV425-Q1, use mode selection pins RSEL0 and RSEL1, as shown in Table 1.

 MODE
 RSEL1
 RSEL0
 DESCRIPTION

 V_{REFOUT} = 2.5 V
 0
 0
 Use with a sensor module supply of 5 V

 V_{REFOUT} = 1.65 V
 0
 1
 Use with a sensor module supply of 3.3 V

 Ratiometric output
 1
 x
 Provides an output centered on VDD / 2

Table 1. Reference Output Voltage Selection

In ratiometric output mode, an internal resistor divider divides the power-supply voltage by a factor of two.

7.3.4 Low-Power Operation

In applications with low-bandwidth or low sample-rate requirements, significantly reduce the average power dissipation of the DRV425-Q1 by powering down the device between measurements. The DRV425-Q1 requires 300 μ s to fully settle the analog output VOUT, as shown in Figure 66. To minimize power dissipation, power down the device immediately after the ADC acquires the sample.

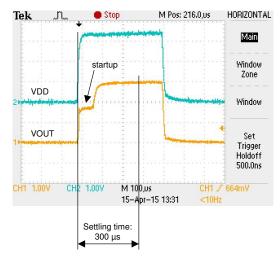


Figure 66. Settling Time of the DRV425-Q1 VOUT Output

7.4 Device Functional Modes

The DRV425-Q1 is operational when the power supply VDD is applied, as specified in the *Specifications* section. The DRV425-Q1 has no additional functional modes.

Product Folder Links: DRV425-Q1



8 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

The DRV425-Q1 is a high-sensitivity and high-performance magnetic-field sensor. The analog output of the DRV425-Q1 can be processed by a 12-bit to 16-bit analog to digital converter (ADC). The following sections show application design examples.

8.2 Typical Applications

8.2.1 Linear Position Sensing

The high sensitivity of the fluxgate sensor, combined with the high linearity of the compensation loop and low noise of the DRV425-Q1, make the device an excellent choice for high-performance linear-position sense applications. A typical schematic of such a 5-V application using an internal 2.5-V reference is shown in Figure 67.

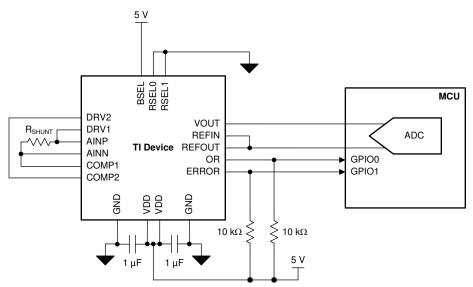


Figure 67. Linear-Position Sensing

8.2.1.1 Design Requirements

For the example shown in Figure 67, use the parameters listed in Table 2 as a starting point of the design.

Table 2. Design Parameters

DESIGN PARAMETER	EXAMPLE VALUE
Magnetic field range	VDD = 5 V: ±2 mT (max) VDD = 3.3 V: ±1.3 mT (max)
Supply voltage, VDD	3.0 V to 5.5 V
Reference voltage, V _{REFIN}	Range: GND to VDD If an internal reference is used: 2.5 V, 1.65 V, or VDD / 2
Shunt resistor, R _{SHUNT}	Depends on the desired magnetic field range, reference, and supply voltage; see the <i>DRV425 System Parameter Calculator</i> for details.

Product Folder Links: DRV425-Q1



8.2.1.2 Detailed Design Procedure

Use the following procedure to design a solution for a linear-position sensor based on the DRV425-Q1:

- Select the proper supply voltage, VDD, to support the desired magnetic field range (see Table 2 for reference).
- 2. Select the proper reference voltage, V_{REFIN}, to support the desired magnetic field range and to match the input voltage specifications of the desired ADC.
- 3. Use the RangeCalculator tab in the DRV425 System Parameter Calculator to select the proper shunt resistor value of R_{SHUNT}.
- 4. The sensitivity drift performance of a DRV425-Q1 based linear position sensor is dominated by the temperature coefficient of the external shunt resistor. Select a low-drift shunt resistor for best sensor performance.
- 5. Use the *Problems Detected Table in DRV425 System Parameters* tab in the *DRV425 System Parameter Calculator* to verify the system response.

The amplitude of the magnetic field is a function of distance to, and the shape of, the magnet, as shown in Figure 69. If the magnetic field to be measured exceeds 3.6 mT, see the magnet datasheet to calculate the appropriate minimum distance to the DRV425-Q1 to avoid saturating the fluxgate sensor.

The high sensitivity of the DRV425-Q1 may require shielding of the sensing area to avoid influence of undesired magnetic field sources (such as the earth magnetic field). Alternatively, an additional DRV425-Q1 can be used to perform difference measurement to cancel the influence of a static magnetic field source, as shown in Figure 68. Figure 70 shows the differential voltage generated by two DRV425-Q1 devices in such a circuit.

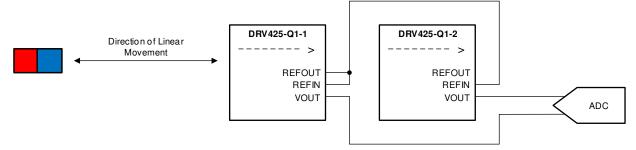
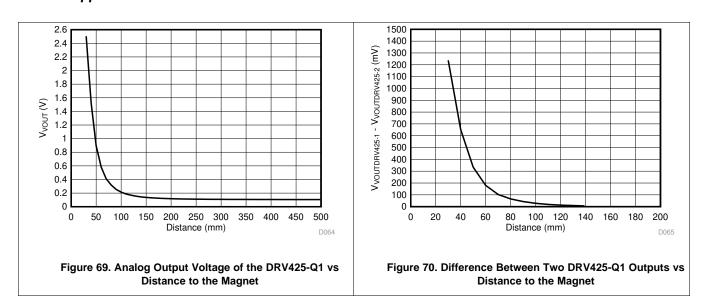


Figure 68. Differential Linear-Position Sensing Using Two DRV425-Q1 Devices

8.2.1.3 Application Curves





8.2.2 Current Sensing in Busbars

In existing applications that use busbars for power distribution, closed-loop current modules are usually used to accurately measure and control the current. These modules are usually bulky because of the required large magnetic core. Additionally, because the compensation current generated inside the module is proportional to the usually high busbar current, the power dissipation of this solution is usually as high as several watts.

Figure 71 shows an alternative approach with two DRV425-Q1 devices. If a hole is drilled in the middle of the busbar, the current is split in two equal parts that generate magnetic field gradients with opposite directions inside the hole. These magnetic fields are termed B_R and B_L in Figure 72. The opposite fields cancel each other out in the middle of the hole. The high sensitivity and linearity of two DRV425-Q1 devices positioned at the same distance from the middle of the hole allow the small opposite fields to be sensed and the current measured with high-accuracy levels. The differential measurement rejects outside fields that generate a common-mode error that is subtracted at the output.

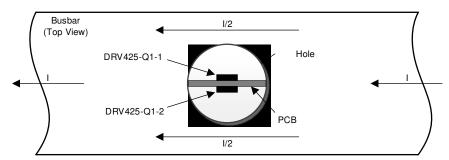


Figure 71. Current Sensing in Busbars

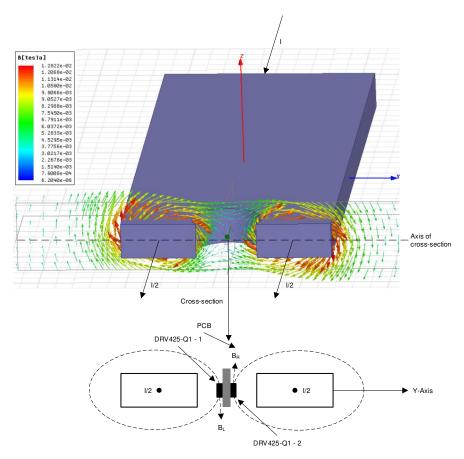


Figure 72. Magnetic Field Distribution Inside a Busbar Hole

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8.2.2.1 Design Requirements

In order to measure the field gradient in the busbar, two DRV425-Q1 sensors are placed inside the hole at a well-defined distance by mounting them on opposite sides of a PCB that is inserted in the hole. measurement range and resolution of this solution depends on the following factors:

- Busbar geometry: a wider busbar means a larger measurement range and lower resolution.
- Size of the hole: a larger diameter means a larger measurement range and lower resolution.
- Distance between the two DRV425-Q1 sensors: a smaller distance increases the measurement range and resolution.

Each of these factors can be optimized to create the desired measurement range for a particular application. Measurement ranges of ±250 A to ±1500 A are achievable with this approach. Larger currents are supported with large busbar structures and minimized distance between the two DRV425-Q1 sensors. Use the parameters listed in Table 3 as a starting point of the design.

Table 3. Design Parameters

DESIGN PARAMETER	EXAMPLE VALUE
Current range	Up to ±1500 A
Supply voltage, VDD	3.0 V to 5.5 V
Reference voltage Vaccini	VDD / 2

8.2.2.2 Detailed Design Procedure

Figure 73 shows the schematic diagram of a differential gradient field measurement circuit.

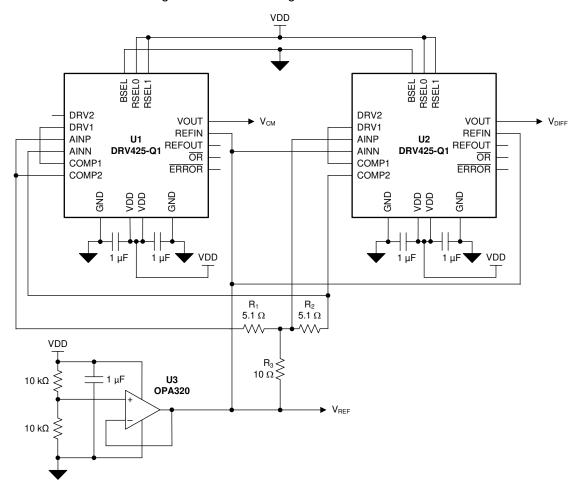


Figure 73. Busbar Current-Sensing Circuit



In Figure 73, the feedback loops of both DRV425-Q1 sensors are combined to directly produce differential output V_{DIFF} that is proportional to the sensed magnetic field difference inside the busbar hole. Both compensation coils are connected in series and are driven from a single side of the compensation coil driver (the DRV1 pins of each DRV425-Q1). Therefore, both driver stages make sure that a current proportional to the magnetic fields B_R and B₁ is driven through the respective compensation coil. The difference in current through both compensation coils, and thus the difference field between the sensors, flows through resistor R₃, and is sensed by the shunt-sense amplifier of U2. The current proportional to the common-mode field inside the busbar hole flows through R₁ and R₂, and is sensed by the shunt-sense amplifier of U1.

Use the output V_{CM} to verify that the sensors are correctly positioned in the busbar hole with the following steps:

- 1. Measure V_{CM} with no current flow through the busbar and the PCB in the middle of the busbar hole. This value is the offset voltage V_{OFESET}. The value of V_{OFESET} only depends on stray fields and varies little with the absolute position of the sensors.
- 2. Apply current through the busbar and move the PCB along the y-axis in the busbar hole, as shown in Figure 72. The PCB is in the center of the hole if $V_{CM} = V_{OFESET}$.

The sensitivity drift performance of the circuit shown in Figure 73 is dominated by the temperature coefficient of the external resistors R₁, R₂, and R₃. Select low-drift resistors for best sensor performance. For overall system error calculation, also consider the affect of thermal expansion on the PCB and busbar.

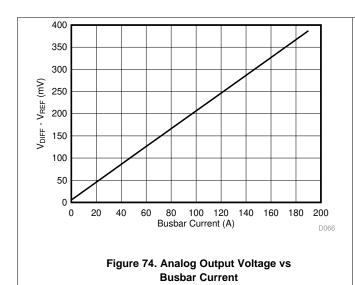
The internal voltage reference of the DRV425-Q1 cannot be used in this application because of its limited driver capability. The OPA320 (U3) is a low-noise operational amplifier with a short-circuit current capability of ±65 mA, and is used to support the required compensation current.

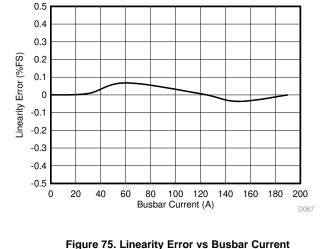
The advantage of this solution is the simplicity: the currents are subtracted by the two DRV425-Q1 devices without additional components. The series connection of the compensation coils halves the voltage swing, and reduces the measurement range of the sensors also by 50%. If a larger sensing range is required, operate the two sensors independently, and use a differential amplifier or ADC to subtract both voltage outputs (VOUT).

Use the ERROR outputs for fast overcurrent detection on the system level.

8.2.2.3 Application Curves

Figure 74 and Figure 75 show the measurement results on a 16-mm wide and 6-mm thick copper busbar with a 12-mm hole diameter using the circuit shown in Figure 73. The two DRV425-Q1 devices are placed at a distance of 1 mm from each other on opposite sides of the PCB. The measurement range is ±500 A; measurement results are limited by test setup. Independent operation of the two DRV425-Q1 sensors increases the measurement range to ±1000 A with the same busbar geometry.





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9 Power Supply Recommendations

9.1 Power Supply Decoupling

Decouple both VDD pins of the DRV425-Q1 with 1-µF, X7R-type ceramic capacitors to the adjacent GND pin, as illustrated in Figure 76. For best performance, place both decoupling capacitors as as possible close to the related power-supply pins. Connect these capacitors to the power-supply source in a way that allows the current to flow through the pads of the decoupling capacitors.

9.2 Power-On Start-Up and Brownout

Power-on is detected when the supply voltage exceeds 2.4 V at the VDD pin. At this point, the DRV425-Q1 initiates the following start-up sequence:

- 1. Digital logic starts up and waits for 26 μ s for the supply to settle.
- 2. The fluxgate sensor powers up.
- 3. The compensation loop is active 70 µs after the supply voltage exceeds 2.4 V.

During this startup sequence, the DRV1 and DRV2 outputs are pulled low to prevent undesired signals on the compensation coil and the ERROR pin is asserted low.

The DRV425-Q1 tests for low supply voltages with a brownout-voltage level of 2.4 V. Use a power-supply source capable of supporting large current pulses driven by the DRV425-Q1, and low-ESR bypass capacitors for a stable supply voltage in the system. A supply drop to less than 2.4 V that lasts longer than 20 µs generates a power-on reset; the device ignores shorter voltage drops. A voltage drop on the VDD pin to below 1.8 V immediately initiates a power-on reset. After the power supply returns to 2.4 V, the device initiates a start-up cycle.

9.3 Power Dissipation

The thermally-enhanced, WQFN package with thermal pad reduces the thermal impedance from junction to case. This package has a downset leadframe to which the die is mounted. The leadframe has an exposed thermal pad on the underside of the package, and provides a good thermal path for heat dissipation.

The power dissipation on both linear outputs DRV1 and DRV2 is calculated with Equation 7:

$$P_{D(DRV)} = I_{DRV} \times (V_{DRV} - V_{SUPPLY})$$

where

- I_{DRV} = supply current as shown in Figure 59.
- V_{DRV} = voltage potential on the DRV1 or DRV2 output pin.
- V_{SUPPLY} = voltage potential closer to V_{DRV} : VDD or GND.

9.3.1 Thermal Pad

Packages with an exposed thermal pad are specifically designed to provide excellent power dissipation, but board layout greatly influences the overall heat dissipation. Technical details are described in the *PowerPad Thermally Enhanced Package*, application report, available for download at www.ti.com.

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10 Layout

10.1 Layout Guidelines

The unique, integrated fluxgate of the DRV425-Q1 has a very high sensitivity that enables designing a closed-loop magnetic-field sensor with best-in-class precision and linearity. Observe proper PCB layout techniques because any current-conducting wire in the direct vicinity of the DRV425-Q1 generates a magnetic field that can distort measurements. Common passive components and some PCB plating materials contain ferromagnetic materials that are magnetizable. For best performance, use the following layout guidelines:

- Route current-conducting wires in pairs: route a wire with an incoming supply current next to, or on top of, the
 return current path. The opposite magnetic field polarity of these connections cancel each other. To facilitate
 this layout approach, the DRV425-Q1 positive and negative supply pins are located adjacently.
- Route the compensation coil connections close to each other as a pair to reduce coupling effects.
- Minimize the length of the compensation coil connections between the DRV1/2 and COMP1/2 pins.
- Route currents parallel to the fluxgate sensor sensitivity axis as illustrated in Figure 76. As a result, magnetic fields are perpendicular to the fluxgate sensitivity and have limited affect.
- Vertical current flow (for example, through vias) generates a field in the fluxgate-sensitive direction. Minimize the number of vias in the vicinity of the DRV425-Q1.
- Use passive components (for example, decoupling capacitors and the shunt resistor) that cannot be magnetized to prevent magnetic effects near the DRV425-Q1.
- Do not use PCB trace finishes with nickel-gold plating because of the potential for magnetization.
- Connect all GND pins to a local ground plane.

Ferrite beads in series with the power-supply connection reduce interaction with other circuits powered from the same supply voltage source. However, to prevent influence of the magnetic fields if ferrite beads are used, do not place them next to the DRV425-Q1.

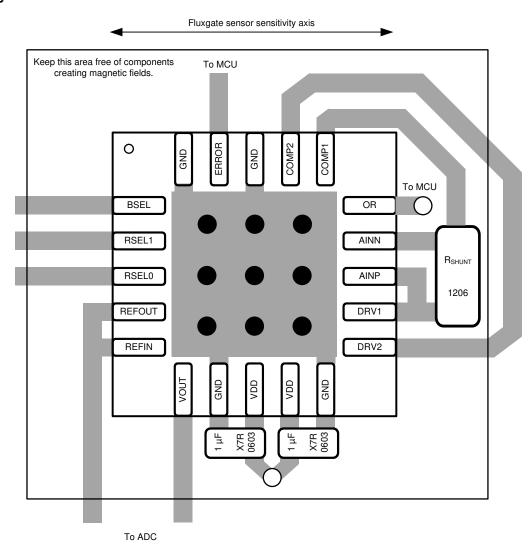
The reference output (the REFOUT pin) refers to GND. Use a low-impedance and star-type connection to reduce the driver current and the fluxgate sensor current modulating the voltage drop on the ground track. The REFOUT and VOUT outputs are able to drive some capacitive load, but avoid large direct capacitive loading because of increased internal pulse currents. Given the wide bandwidth of the shunt-sense amplifier, isolate large capacitive loads with a small series resistor.

Solder the exposed thermal pad on the bottom of the package to the ground layer because the thermal pad is internally connected to the substrate that must be connected to the most-negative potential.

Figure 76 illustrates a generic layout example that highlights the placement of components that are critical to the DRV425-Q1 performance. For specific layout examples, see the *DRV425EVM* users guide.



10.2 Layout Example



LEGEND

Top Layer:
Copper Pour and Traces

Via to Ground Plane

Via to Supply Plane

Figure 76. Generic Layout Example (Top View)



11 Device and Documentation Support

11.1 Documentation Support

11.1.1 Related Documentation

For related documentation see the following:

- Texas Instruments, OPAx320 Precision, 20-MHz, Low-Noise, Low-Power, RRIO, CMOS Op Amp With Shutdown data sheet
- Texas Instruments, DRV425EVM user's guide
- Texas Instruments, DRV425 System Parameter Calculator
- Texas Instruments, PowerPad Thermally Enhanced Package application report
- Texas Instruments, ±100-A Busbar Current Sensor Reference Design Using Open-Loop Fluxgate Sensors reference design TIPD205
- Texas Instruments, Bus Bar Theory of Operation application report

11.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on Alert me to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

11.3 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the guick design help you need.

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11.4 Trademarks

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11.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.



ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

11.6 Glossary

SLYZ022 — TI Glossarv.

This glossary lists and explains terms, acronyms, and definitions.

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



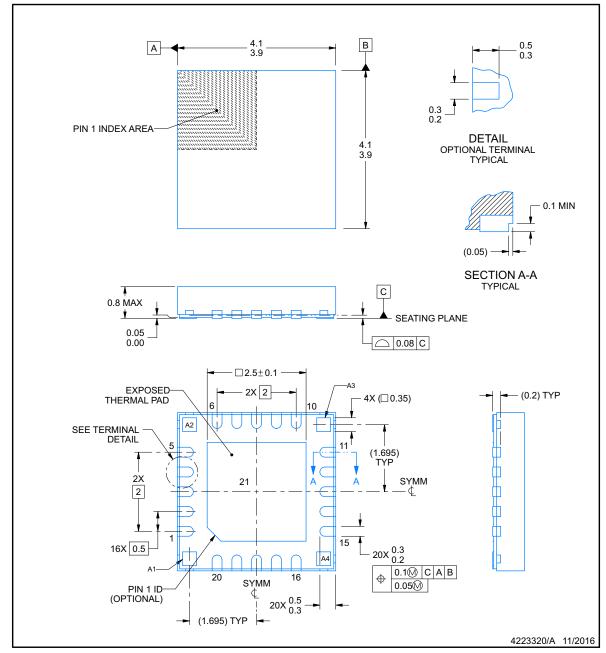
RTJ0020J



PACKAGE OUTLINE

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

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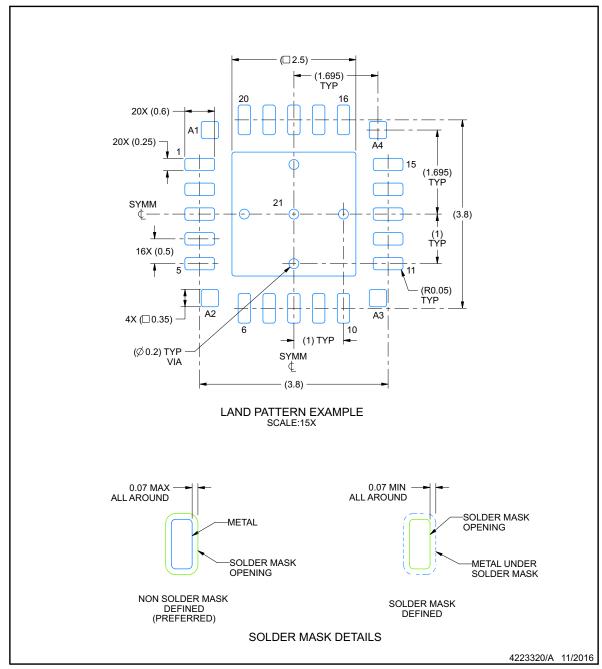


EXAMPLE BOARD LAYOUT

RTJ0020J

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

- This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
 Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

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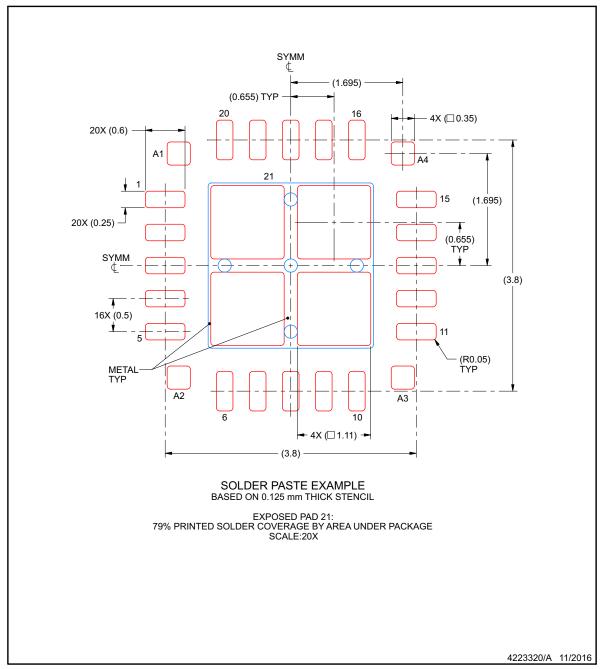


EXAMPLE STENCIL DESIGN

RTJ0020J

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
						(4)	(5)		
DRV425QWRTJRQ1	Active	Production	QFN (RTJ) 20	3000 LARGE T&R	Yes	SN	Level-2-260C-1 YEAR	-40 to 125	>
									425-Q1
DRV425QWRTJRQ1.A	Active	Production	QFN (RTJ) 20	3000 LARGE T&R	Yes	SN	Level-2-260C-1 YEAR	-40 to 125	>
									425-Q1

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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OTHER QUALIFIED VERSIONS OF DRV425-Q1:

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE OPTION ADDENDUM

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NOTE: Qualified Version Definitions:

• Catalog - TI's standard catalog product

PACKAGE MATERIALS INFORMATION

www.ti.com 20-Apr-2023

TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DRV425QWRTJRQ1	QFN	RTJ	20	3000	330.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2

PACKAGE MATERIALS INFORMATION

www.ti.com 20-Apr-2023



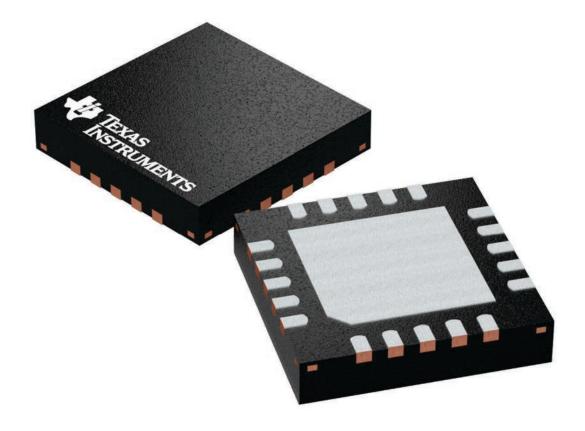
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
DRV425QWRTJRQ1	QFN	RTJ	20	3000	346.0	346.0	33.0	

4 x 4, 0.5 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



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